## Application/Control No. Applicant(s)/Patent Under Reexamination 10/064,672 LAI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2632 Brian L. De Grano **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0041588 11-2001 Hollstrom et al. 455/556 Α US-2002/0173344 11-2002 Cupps et al. 455/566 В Timis et al. 84/609 С US-5,792,971 08-1998 455/550.1 D US-6,944,474 09-2005 Rader et al. US-Ε US-F US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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